Application/Control No. Applicant(s)/Patent Under Reexamination 10/780,244 HEO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Remmon R. Fordé 2826 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 01-2001 Chen et al. 438/584 US-6,177,334 Α US-В US-С US-D US-Ε US-F G US-US-Н US-J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.